

Search Notes

Application/Control No.

10/630,222

Examiner

Shih-wen Hsieh

Applicant(s)/Patent under
Reexamination

TAKAGI ET AL.

Art Unit

2861

SEARCHED

Class	Subclass	Date	Examiner
updated	updated	11/10/2005	<i>hwh</i> SWH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
USPGPUB text search (see attached)		11/10/2005	<i>hwh</i> SWH

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR